

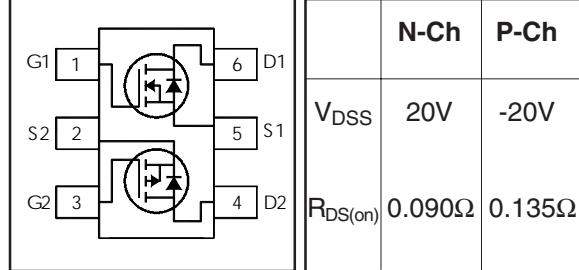
# International IR Rectifier

PD-93998B

## IRF5851

HEXFET® Power MOSFET

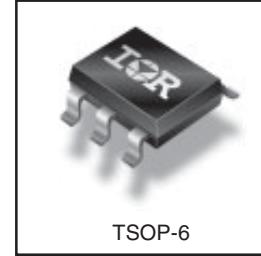
- Ultra Low On-Resistance
- Dual N and P Channel MOSFET
- Surface Mount
- Available in Tape & Reel
- Low Gate Charge



### Description

These N and P channel MOSFETs from International Rectifier utilize advanced processing techniques to achieve the extremely low on-resistance per silicon area. This benefit provides the designer with an extremely efficient device for use in battery and load management applications.

This Dual TSOP-6 package is ideal for applications where printed circuit board space is at a premium and where maximum functionality is required. With two die per package, the IRF5851 can provide the functionality of two SOT-23 packages in a smaller footprint. Its unique thermal design and  $R_{DS(on)}$  reduction enables an increase in current-handling capability.



### Absolute Maximum Ratings

	Parameter	Max.		Units
		N-Channel	P-Channel	
$V_{DS}$	Drain-to-Source Voltage	20	-20	A
$I_D @ T_A = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	2.7	-2.2	
$I_D @ T_A = 70^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	2.2	-1.7	
$I_{DM}$	Pulsed Drain Current ①	11	-9.0	
$P_D @ T_A = 25^\circ C$	Power Dissipation ③	0.96		
$P_D @ T_A = 70^\circ C$	Power Dissipation ③	0.62		W
	Linear Derating Factor	7.7		
$V_{GS}$	Gate-to-Source Voltage	± 12		V
$T_J, T_{STG}$	Junction and Storage Temperature Range	-55 to + 150		°C

### Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{\theta JA}$	Maximum Junction-to-Ambient ③	—	130	°C/W

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## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	N-Ch 20	—	—	V	$V_{GS} = 0\text{V}, I_D = 250\mu\text{A}$
		P-Ch -20	—	—		$V_{GS} = 0\text{V}, I_D = -250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	N-Ch —	0.016	—	$\text{V}/^\circ\text{C}$	Reference to $25^\circ\text{C}$ , $I_D = 1\text{mA}$
		P-Ch —	-0.011	—		Reference to $25^\circ\text{C}$ , $I_D = -1\text{mA}$
$R_{DS(\text{ON})}$	Static Drain-to-Source On-Resistance	N-Ch —	—	0.090	$\Omega$	$V_{GS} = 4.5\text{V}, I_D = 2.7\text{A}$ ②
		—	—	0.120		$V_{GS} = 2.5\text{V}, I_D = 2.2\text{A}$ ②
		P-Ch —	—	0.135		$V_{GS} = -4.5\text{V}, I_D = -2.2\text{A}$ ②
		—	—	0.220		$V_{GS} = -2.5\text{V}, I_D = -1.7\text{A}$ ②
$V_{GS(\text{th})}$	Gate Threshold Voltage	N-Ch 0.60	—	1.25	V	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$
		P-Ch -0.45	—	-1.2		$V_{DS} = V_{GS}, I_D = -250\mu\text{A}$
$g_{fs}$	Forward Transconductance	N-Ch 5.2	—	—	S	$V_{DS} = 10\text{V}, I_D = 2.7\text{A}$ ②
		P-Ch 3.5	—	—		$V_{DS} = -10\text{V}, I_D = -2.2\text{A}$ ②
$I_{DSS}$	Drain-to-Source Leakage Current	N-Ch —	—	1.0	$\mu\text{A}$	$V_{DS} = 16\text{V}, V_{GS} = 0\text{V}$
		P-Ch —	—	-1.0		$V_{DS} = -16\text{V}, V_{GS} = 0\text{V}$
		N-Ch —	—	25		$V_{DS} = 16\text{V}, V_{GS} = 0\text{V}, T_J = 70^\circ\text{C}$
		P-Ch —	—	-25		$V_{DS} = -16\text{V}, V_{GS} = 0\text{V}, T_J = 70^\circ\text{C}$
$I_{GSS}$	Gate-to-Source Forward Leakage	N-P —	—	$\pm 100$		$V_{GS} = \pm 12\text{V}$
$Q_g$	Total Gate Charge	N-Ch —	4.0	6.0	nC	N-Channel
		P-Ch —	3.6	5.4		$I_D = 2.7\text{A}, V_{DS} = 10\text{V}, V_{GS} = 4.5\text{V}$ ②
$Q_{gs}$	Gate-to-Source Charge	N-Ch —	0.95	—		P-Channel
		P-Ch —	0.66	—		$I_D = -2.2\text{A}, V_{DS} = -10\text{V}, V_{GS} = -4.5\text{V}$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge	N-Ch —	0.83	—	ns	N-Channel
		P-Ch —	5.7	—		$V_{DD} = 10\text{V}, I_D = 1.0\text{A}, R_G = 6.2\Omega, V_{GS} = 4.5\text{V}$ ②
$t_{d(on)}$	Turn-On Delay Time	N-Ch —	6.6	—		P-Channel
		P-Ch —	8.3	—		$V_{DD} = -10\text{V}, I_D = -1.0\text{A}, R_G = 6.0\Omega, V_{GS} = -4.5\text{V}$
$t_r$	Rise Time	N-Ch —	1.2	—	pF	N-Channel
		P-Ch —	14	—		$V_{GS} = 0\text{V}, V_{DS} = 15\text{V}, f = 1.0\text{MHz}$
$t_{d(off)}$	Turn-Off Delay Time	N-Ch —	15	—		P-Channel
		P-Ch —	31	—		$V_{GS} = 0\text{V}, V_{DS} = -15\text{V}, f = 1.0\text{MHz}$
$t_f$	Fall Time	N-Ch —	2.4	—		N-Channel
		P-Ch —	28	—		$P-Channel$
$C_{iss}$	Input Capacitance	N-Ch —	400	—		$V_{GS} = 0\text{V}, V_{DS} = 15\text{V}, f = 1.0\text{MHz}$
		P-Ch —	320	—		$P-Channel$
$C_{oss}$	Output Capacitance	N-Ch —	48	—		$V_{GS} = 0\text{V}, V_{DS} = -15\text{V}, f = 1.0\text{MHz}$
		P-Ch —	56	—		
$C_{rss}$	Reverse Transfer Capacitance	N-Ch —	32	—		
		P-Ch —	40	—		

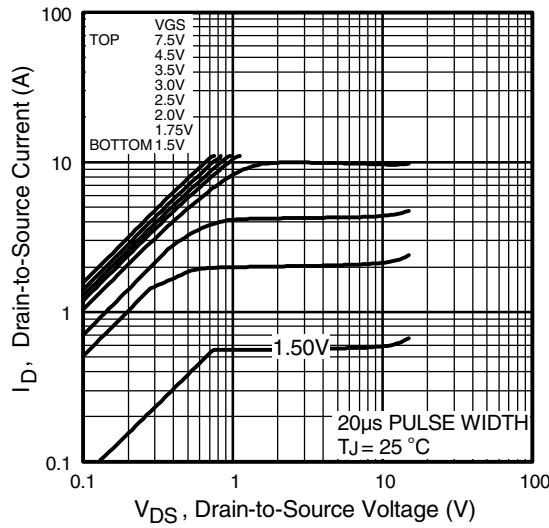
## Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	N-Ch —	—	0.96	A	
		P-Ch —	—	-0.96		
$I_{SM}$	Pulsed Source Current (Body Diode) ①	N-Ch —	—	11	V	$T_J = 25^\circ\text{C}, I_S = 0.96\text{A}, V_{GS} = 0\text{V}$ ②
		P-Ch —	—	-9.0		$T_J = 25^\circ\text{C}, I_S = -0.96\text{A}, V_{GS} = 0\text{V}$ ②
$V_{SD}$	Diode Forward Voltage	N-Ch —	—	1.2	ns	
		P-Ch —	—	-1.2		
$t_{rr}$	Reverse Recovery Time	N-Ch —	25	38	nC	N-Channel
		P-Ch —	23	35		$T_J = 25^\circ\text{C}, I_F = 0.96\text{A}, di/dt = 100\text{A}/\mu\text{s}$
$Q_{rr}$	Reverse Recovery Charge	N-Ch —	6.5	9.8	nC	P-Channel
		P-Ch —	7.7	12		$T_J = 25^\circ\text{C}, I_F = -0.96\text{A}, di/dt = -100\text{A}/\mu\text{s}$ ②

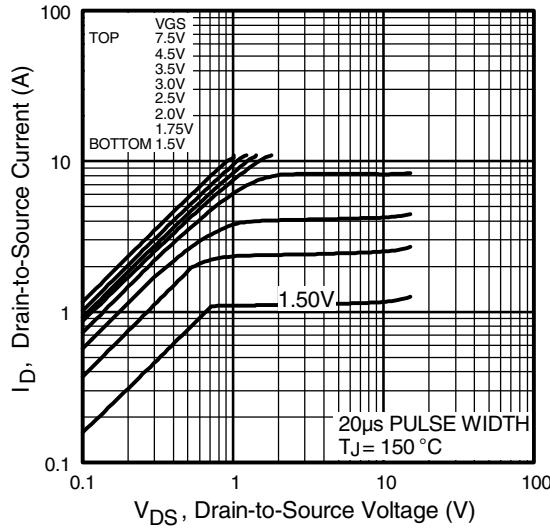
### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. ( See fig. 10 & 26 )
- ② Pulse width  $\leq 400\mu\text{s}$ ; duty cycle  $\leq 2\%$ .

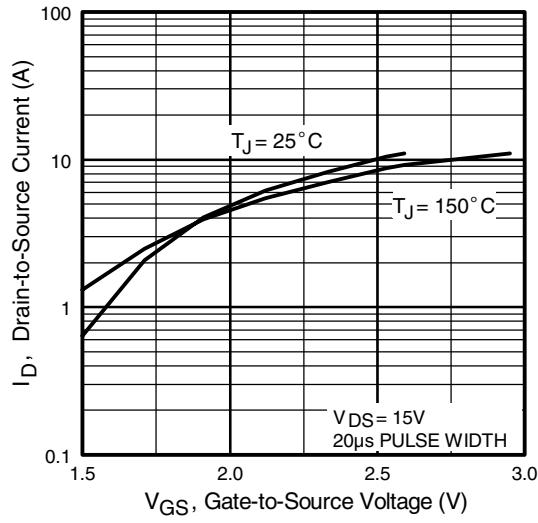
③ Surface mounted on FR-4 board,  $t \leq 10\text{sec}$ .



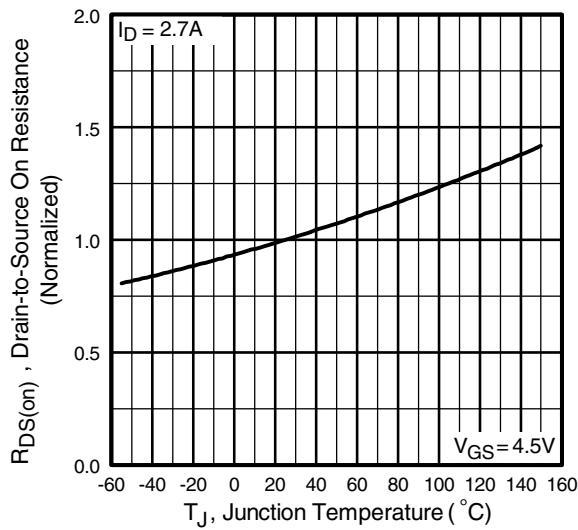
**Fig 1.** Typical Output Characteristics



**Fig 2.** Typical Output Characteristics



**Fig 3.** Typical Transfer Characteristics

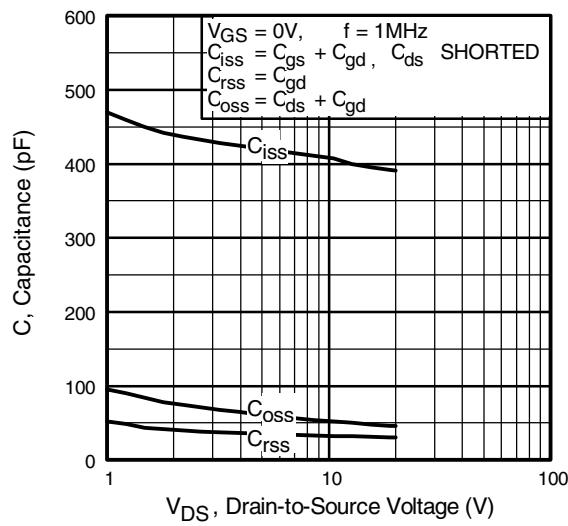


**Fig 4.** Normalized On-Resistance  
 Vs. Temperature

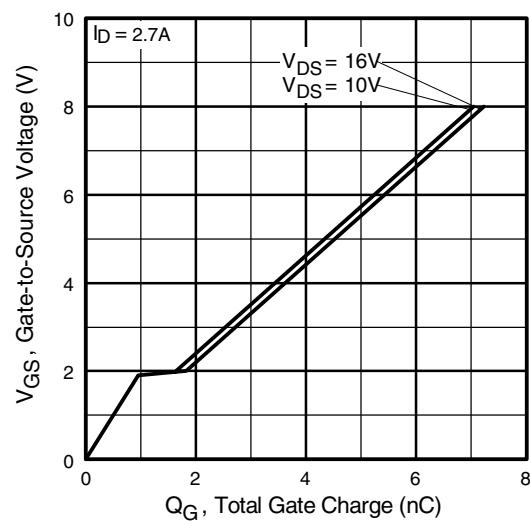
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N-Channel

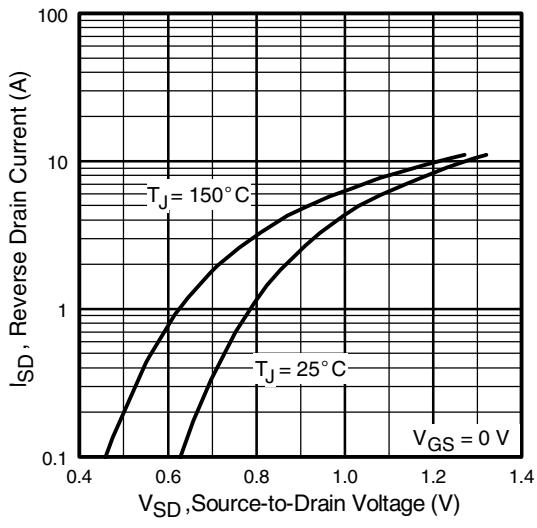
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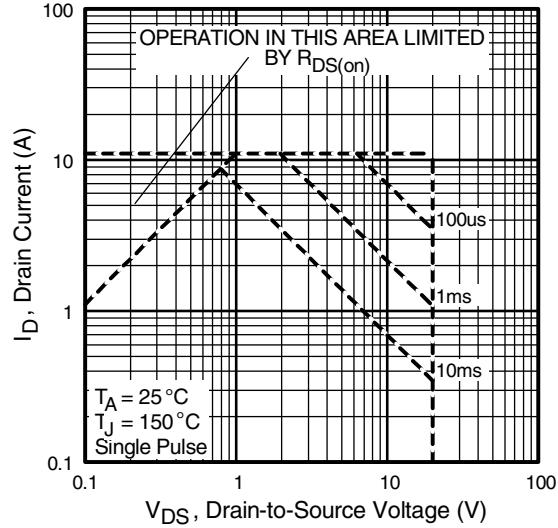
**Fig 5.** Typical Capacitance Vs.  
Drain-to-Source Voltage



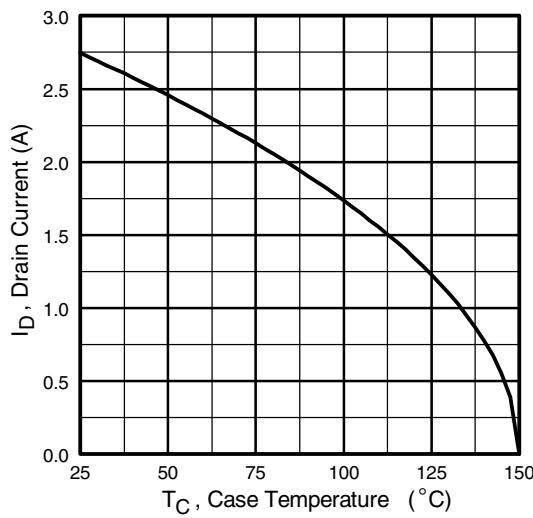
**Fig 6.** Typical Gate Charge Vs.  
Gate-to-Source Voltage



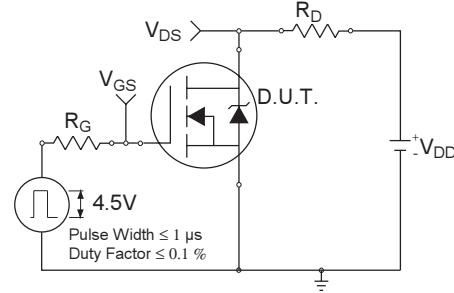
**Fig 7.** Typical Source-Drain Diode  
Forward Voltage



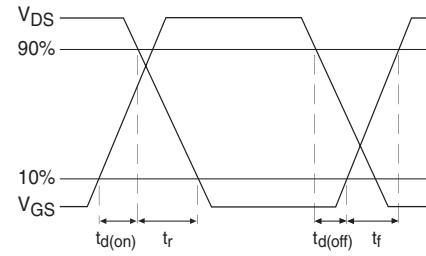
**Fig 8.** Maximum Safe Operating Area



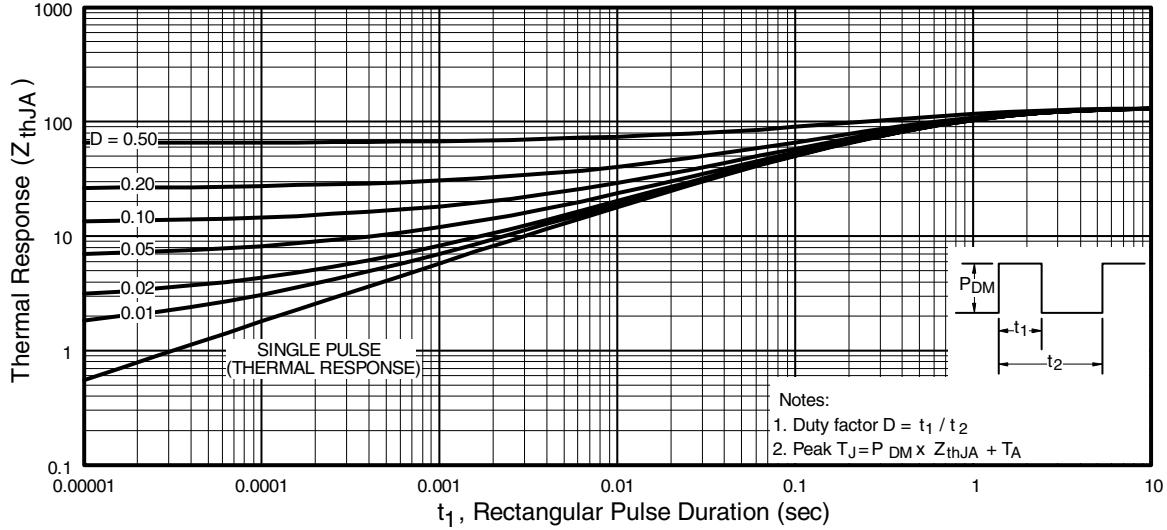
**Fig 9.** Maximum Drain Current Vs.  
Case Temperature



**Fig 10a.** Switching Time Test Circuit



**Fig 10b.** Switching Time Waveforms

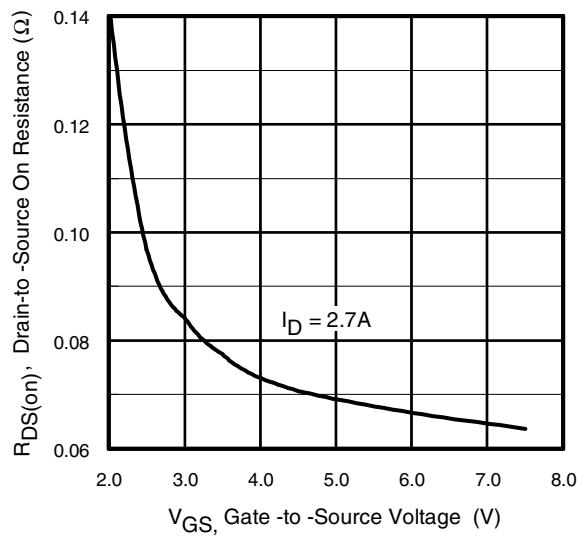


**Fig 10.** Typical Effective Transient Thermal Impedance, Junction-to-Ambient

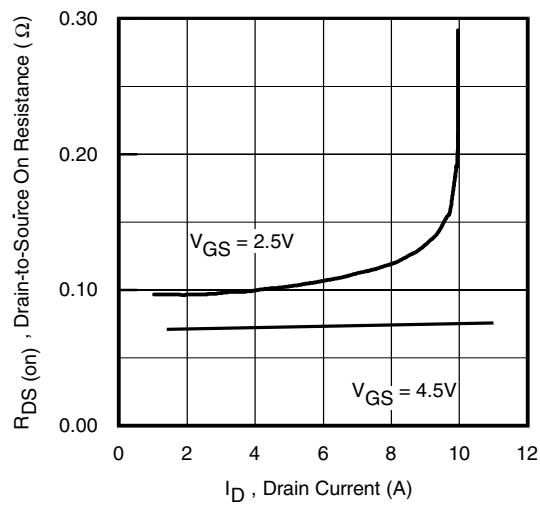
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N-Channel

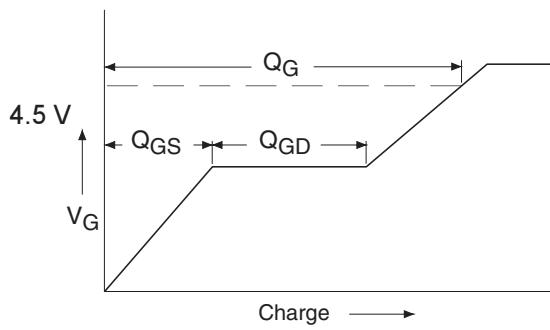
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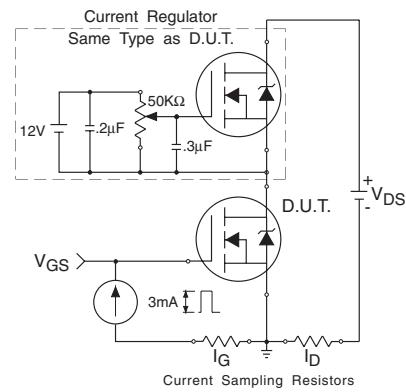
**Fig 11.** Typical On-Resistance Vs. Gate Voltage



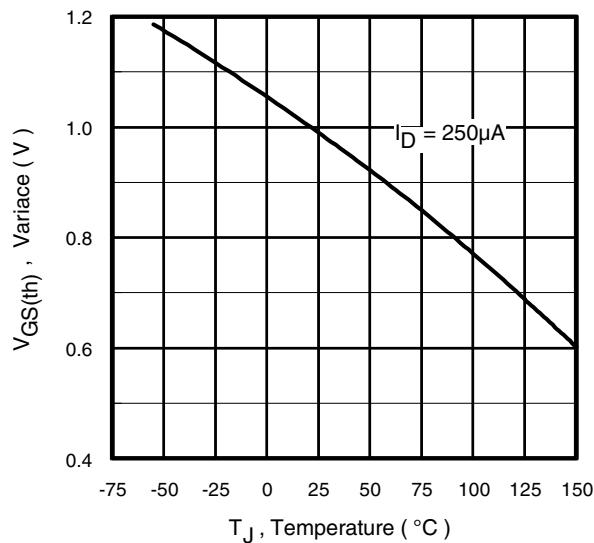
**Fig 12.** Typical On-Resistance Vs. Drain Current



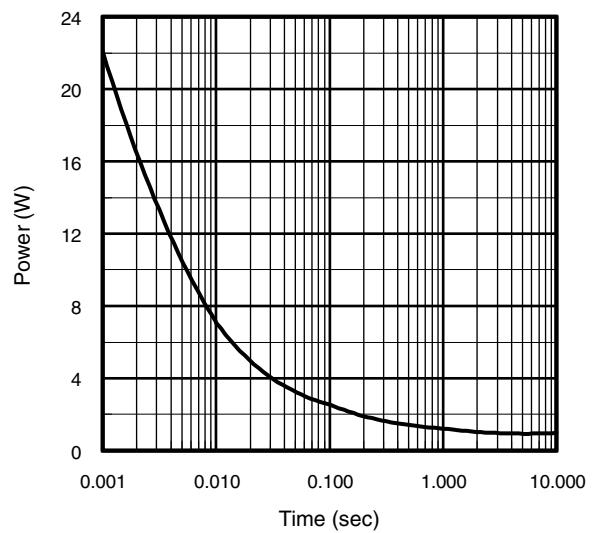
**Fig 13a.** Basic Gate Charge Waveform



**Fig 13b.** Gate Charge Test Circuit



**Fig 14.** Threshold Voltage Vs. Temperature

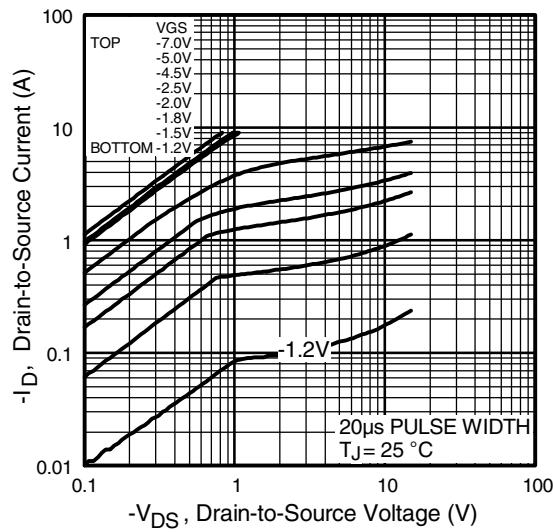


**Fig 15.** Typical Power Vs. Time

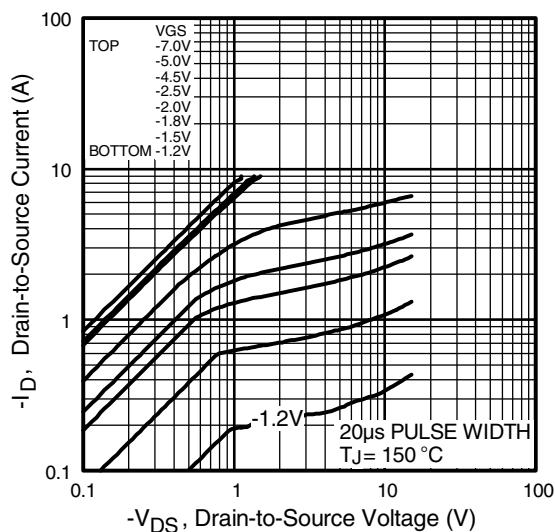
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P-Channel

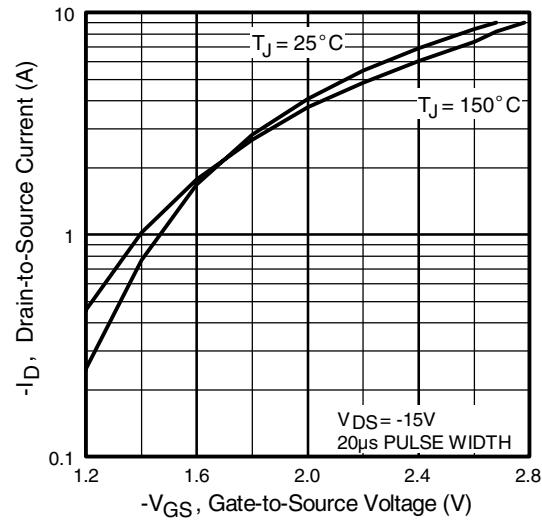
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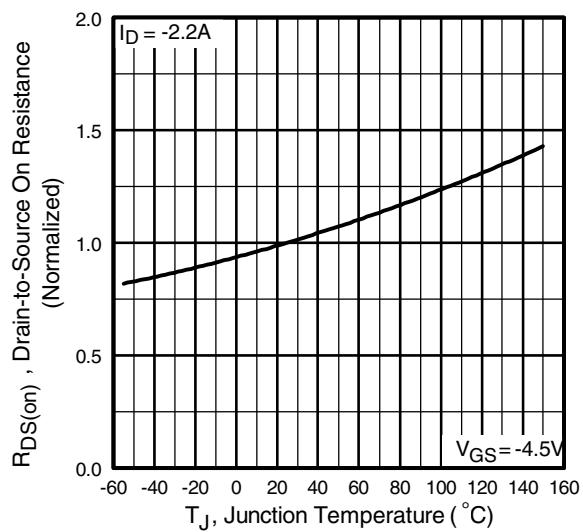
**Fig 16.** Typical Output Characteristics



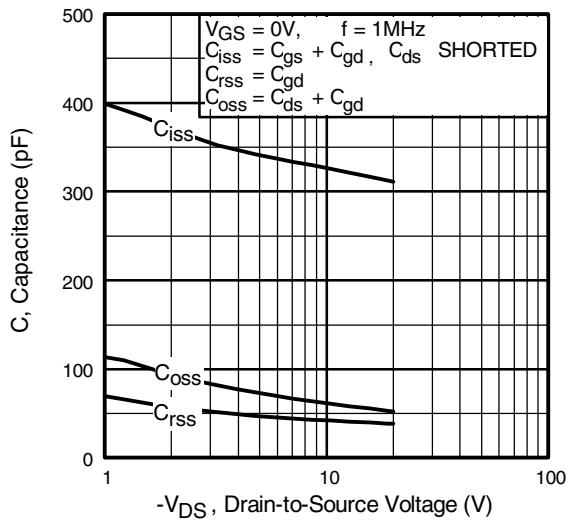
**Fig 17.** Typical Output Characteristics



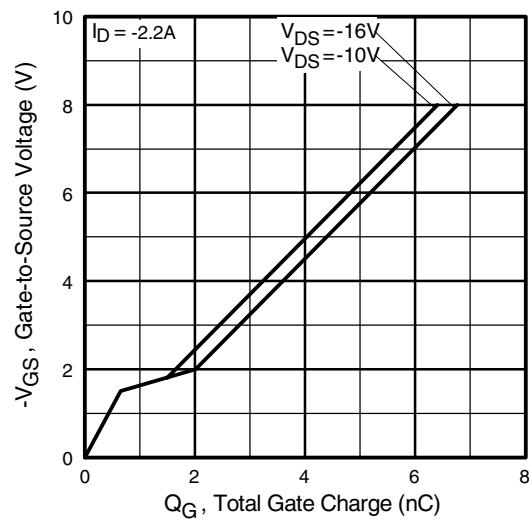
**Fig 18.** Typical Transfer Characteristics



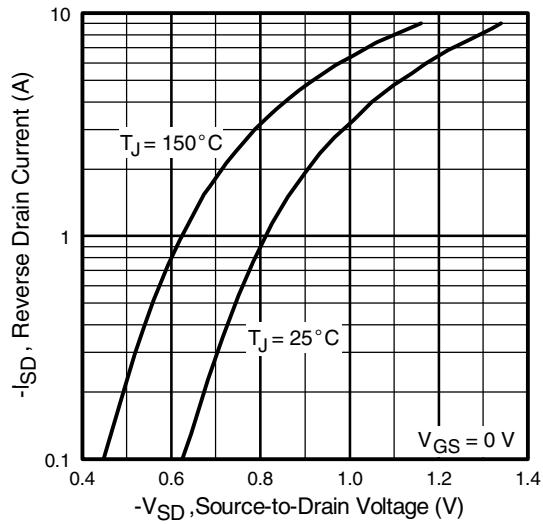
**Fig 19.** Normalized On-Resistance Vs. Temperature



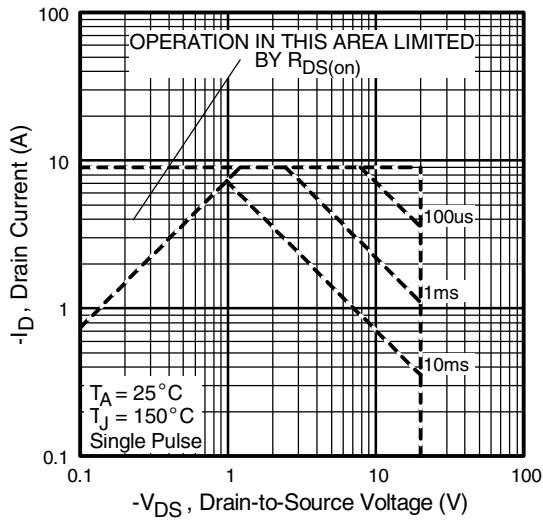
**Fig 20.** Typical Capacitance Vs.  
Drain-to-Source Voltage



**Fig 21.** Typical Gate Charge Vs.  
Gate-to-Source Voltage



**Fig 22.** Typical Source-Drain Diode  
Forward Voltage

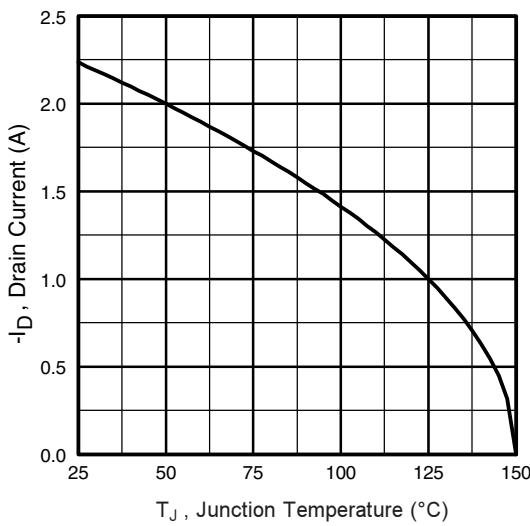


**Fig 23.** Maximum Safe Operating Area

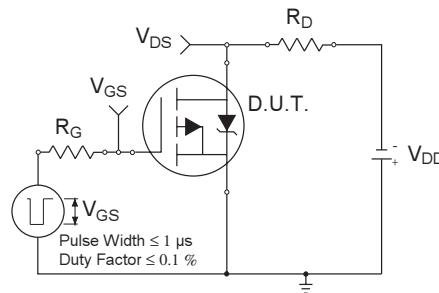
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P-Channel

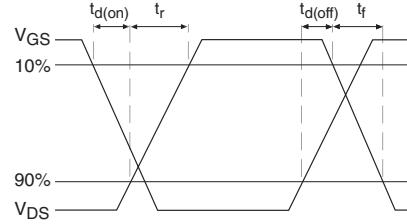
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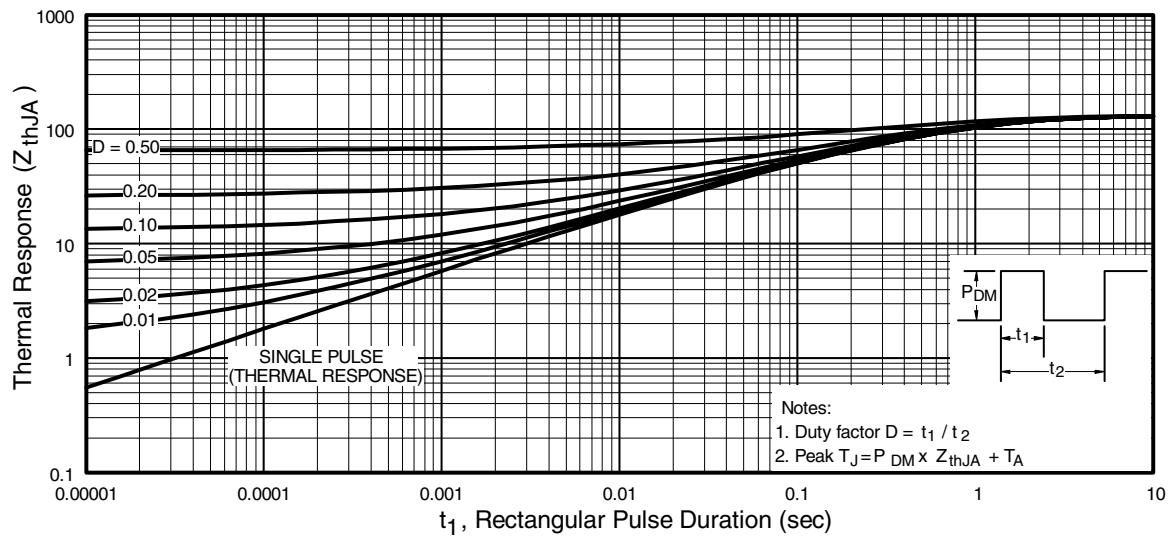
**Fig 24.** Maximum Drain Current Vs. Junction Temperature



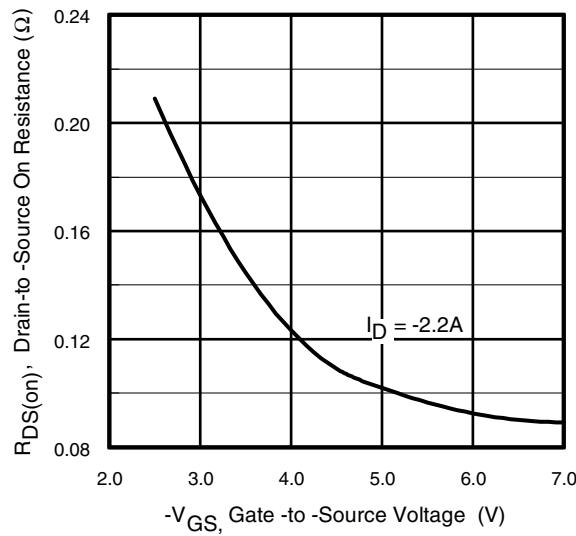
**Fig 25a.** Switching Time Test Circuit



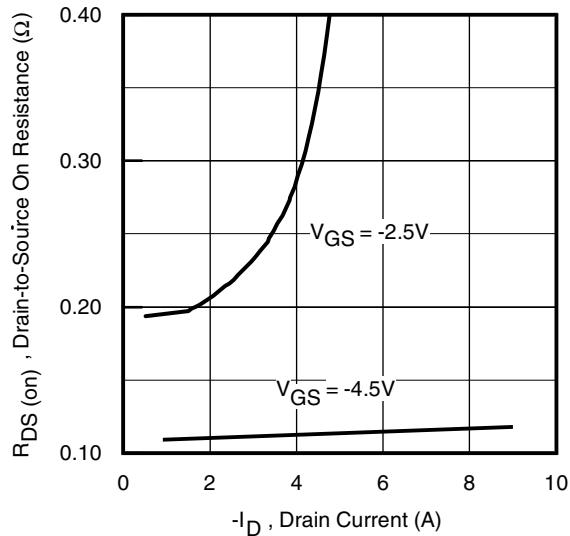
**Fig 25b.** Switching Time Waveforms



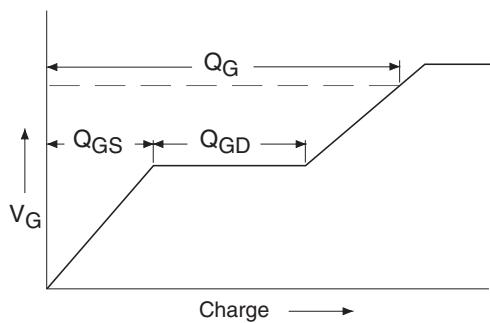
**Fig 26.** Typical Effective Transient Thermal Impedance, Junction-to-Ambient



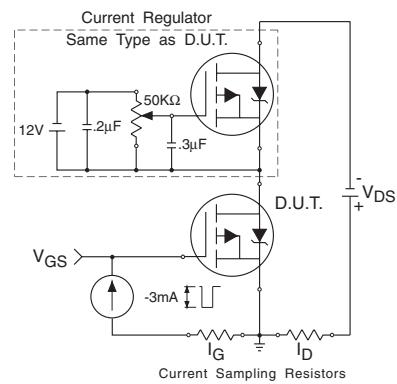
**Fig 27.** Typical On-Resistance Vs. Gate Voltage



**Fig 28.** Typical On-Resistance Vs. Drain Current



**Fig 29a.** Basic Gate Charge Waveform



**Fig 29b.** Gate Charge Test Circuit

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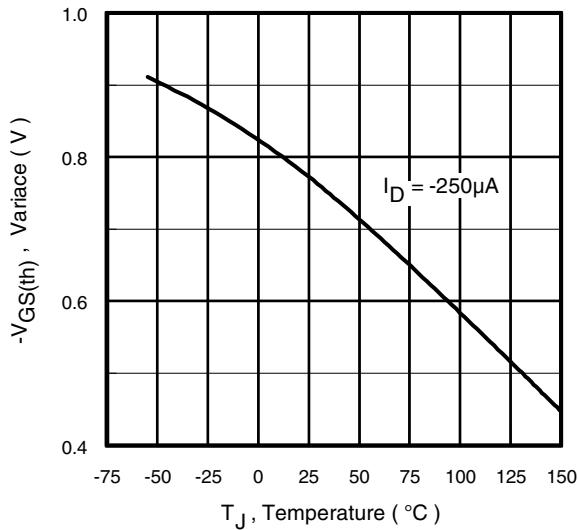


Fig 30. Threshold Voltage Vs. Temperature

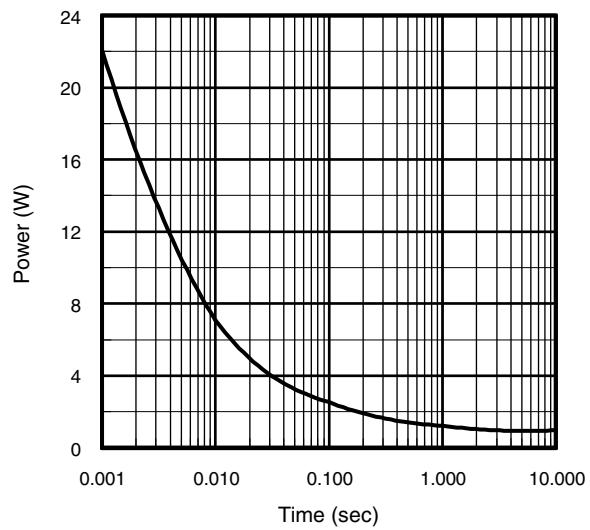
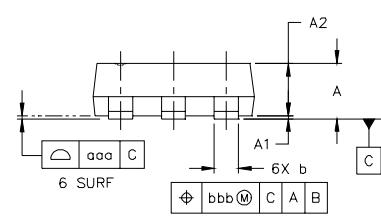
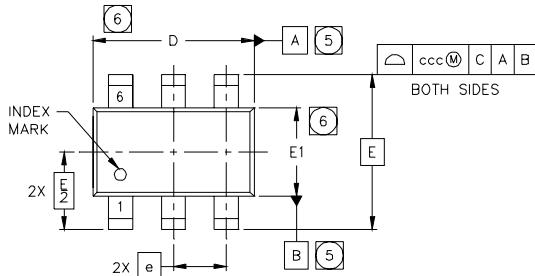
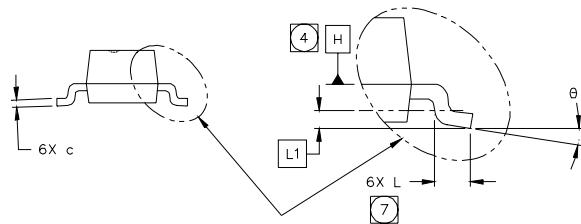


Fig 31. Typical Power Vs. Time

## TSOP-6 Package Outline

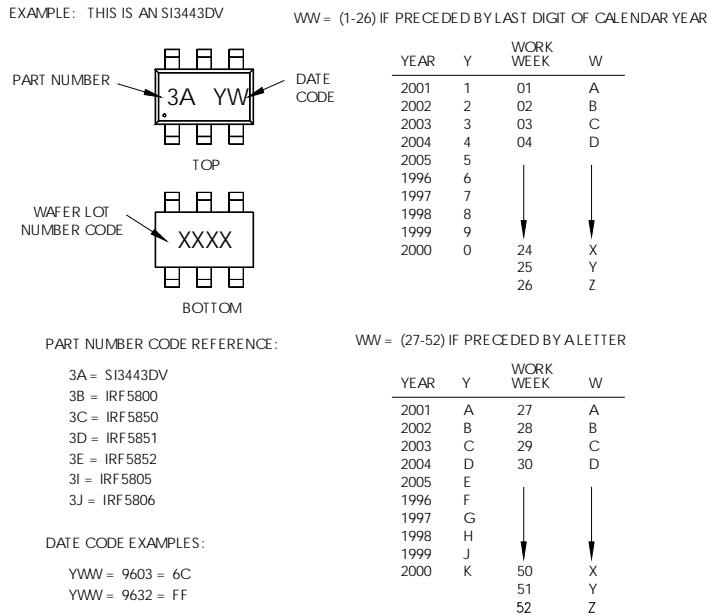


SYMBOL	MO-19.3AA DIMENSIONS					
	MILLIMETERS			INCHES		
	MIN	NOM	MAX	MIN	NOM	MAX
A	---	---	1.10	---	---	.0433
A1	0.01	---	0.10	.0004	---	.0039
A2	0.80	0.90	1.00	.0315	.0354	.0393
b	0.25	---	0.50	.0099	---	.0196
c	0.10	---	0.26	.004	---	.010
D	2.90	3.00	3.10	.115	.118	.122
E	2.75 BSC			.108 BSC		
E1	1.30	1.50	1.70	.052	.059	.066
e	1.00 BSC			.039 BSC		
L	0.20	0.40	0.60	.0079	.0157	.0236
L1	0.30 BSC			.0118 BSC		
θ	0°	---	8°	0°	---	8°
aaa	0.10			.004		
bbb	0.15			.006		
ccc	0.25			.010		



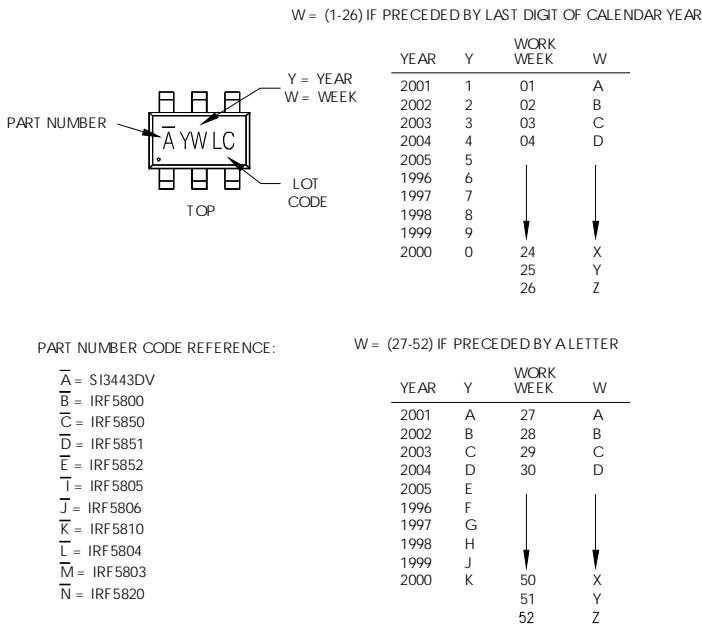
## TSOP-6 Part Marking Information (Old)

Note: This part marking information applies to devices produced before 02/26/2001.

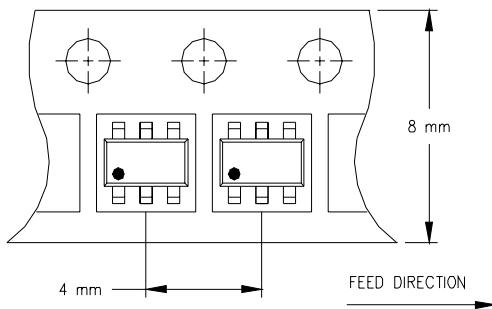


## TSOP-6 Part Marking Information (New)

Note: This part marking information applies to devices produced after 02/26/2001.

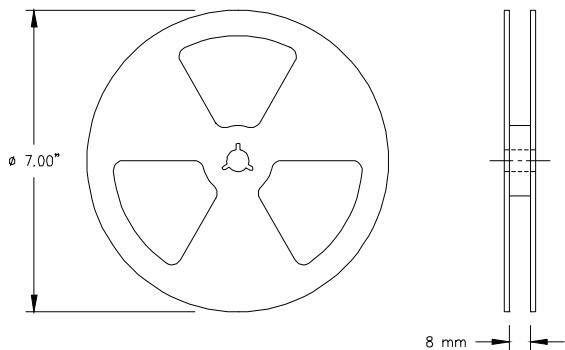


## TSOP-6 Tape & Reel Information



NOTES:

1. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES:

1. OUTLINE CONFORMS TO EIA-481 & EIA-541.

Data and specifications subject to change without notice.  
This product has been designed and qualified for the Industrial market.  
Qualification Standards can be found on IR's Web site.

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**IR** Rectifier

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